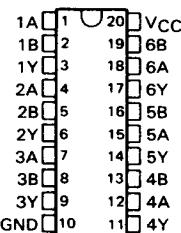


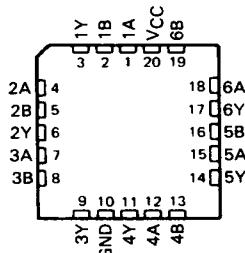
- High-Current Outputs Can Drive Up to 15 LSTTL Loads
- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

**SN54HC805 . . . J PACKAGE**  
**SN74HC805 . . . DW OR N PACKAGE**

(TOP VIEW)



**SN54HC805 . . . FK PACKAGE**  
(TOP VIEW)



## description

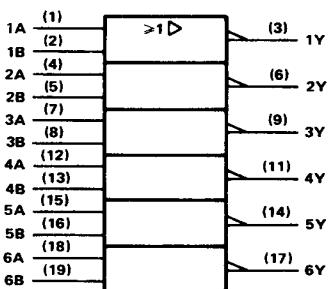
These devices contain six independent 2-input NOR drivers. They perform the Boolean functions  $Y = A + B$  or  $Y = \bar{A} \cdot \bar{B}$  in positive logic.

The SN54HC805 is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74HC805 is characterized for operation from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

**FUNCTION TABLE  
(EACH DRIVER)**

INPUTS		OUTPUT
A	B	Y
H	X	L
X	H	L
L	L	H

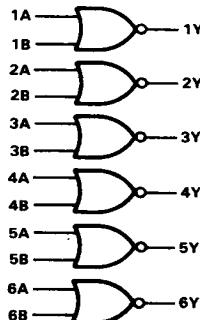
## logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for DW, J, and N packages.

## logic diagram (positive logic)



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**HCMOS Devices**

# SN54HC805, SN74HC805 HEX 2-INPUT NOR DRIVERS

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HCMOS Devices

## absolute maximum ratings over operating free-air temperature range<sup>†</sup>

Supply voltage, V <sub>CC</sub> . . . . .	-0.5 V to 7 V
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>CC</sub> ) . . . . .	±20 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> ) . . . . .	±20 mA
Continuous output current, I <sub>O</sub> (V <sub>O</sub> = 0 to V <sub>CC</sub> ) . . . . .	±25 mA
Continuous current through V <sub>CC</sub> or GND pins . . . . .	±50 mA
Lead temperature 1.6 mm (1/16 in) from case for 60 s: FK or J package . . . . .	300°C
Lead temperature 1.6 mm (1/16 in) from case for 10 s: DW or N package . . . . .	260°C
Storage temperature range . . . . .	-65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## recommended operating conditions

		SN54HC805			SN74HC805			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V <sub>CC</sub>	Supply voltage	2	5	6	2	5	6	V
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 2 V V <sub>CC</sub> = 4.5 V V <sub>CC</sub> = 6 V	1.5 3.15 4.2		1.5 3.15 4.2			V
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 2 V V <sub>CC</sub> = 4.5 V V <sub>CC</sub> = 6 V	0 0 0	0.3 0.9 1.2	0 0 0	0.3 0.9 1.2		V
V <sub>I</sub>	Input voltage		0	V <sub>CC</sub>	0	V <sub>CC</sub>	V <sub>CC</sub>	V
V <sub>O</sub>	Output voltage		0	V <sub>CC</sub>	0	V <sub>CC</sub>	V <sub>CC</sub>	V
t <sub>t</sub>	Input transition (rise and fall) times	V <sub>CC</sub> = 2 V V <sub>CC</sub> = 4.5 V V <sub>CC</sub> = 6 V	0 0 0	1000 500 400	0 0 0	1000 500 400		ns
T <sub>A</sub>	Operating free-air temperature		-55	125	-40	85	85	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	T <sub>A</sub> = 25°C			SN54HC805		SN74HC805		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V <sub>OH</sub>	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> , I <sub>OH</sub> = -20 µA	2 V	1.9	1.998		1.9		1.9		V
		4.5 V	4.4	4.499		4.4		4.4		
		6 V	5.9	5.999		5.9		5.9		
	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> , I <sub>OH</sub> = -6 mA	4.5 V	3.98	4.30		3.7		3.84		
V <sub>OL</sub>	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> , I <sub>OL</sub> = 20 µA	6 V	5.48	5.80		5.2		5.34		V
		2 V	0.002	0.1		0.1		0.1		
		4.5 V	0.001	0.1		0.1		0.1		
		6 V	0.001	0.1		0.1		0.1		
V <sub>I</sub>	V <sub>I</sub> = V <sub>CC</sub> or 0	4.5 V	0.17	0.26		0.4		0.33		V
	V <sub>I</sub> = V <sub>CC</sub> or 0, I <sub>O</sub> = 0	6 V	0.15	0.26		0.4		0.33		
C <sub>i</sub>		2 to 6 V	3	10		10		10	pF	

**SN54HC805, SN74HC805  
HEX 2-INPUT NOR DRIVERS**

**switching characteristics over recommended operating free-air temperature range (unless otherwise noted),  $C_L = 50 \text{ pF}$  (see Note 1)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub>	T <sub>A</sub> = 25 °C			SN54HC805		SN74HC805		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t <sub>pd</sub>	A or B	Y	2 V	31	95		145		120		ns
			4.5 V	10	19		29		24		
			6 V	8	16		25		20		
t <sub>t</sub>		Any	2 V	28	60		90		75		ns
			4.5 V	8	12		18		15		
			6 V	6	10		15		13		
C <sub>pd</sub>	Power dissipation capacitance per gate			No load, T <sub>A</sub> = 25 °C			40 pF typ				

**switching characteristics over recommended operating free-air temperature range (unless otherwise noted),  $C_L = 150 \text{ pF}$  (see Note 1)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub>	T <sub>A</sub> = 25 °C			SN54HC805		SN74HC805		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t <sub>pd</sub>	A or B	Y	2 V	44	180		275		225		ns
			4.5 V	14	36		55		45		
			6 V	11	31		47		39		
t <sub>t</sub>		Any	2 V	45	210		315		265		ns
			4.5 V	17	42		63		53		
			6 V	13	36		53		45		

Note 1: Load circuits and voltage waveforms are shown in Section 1.

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